

MOS FIELD EFFECT TRANSISTOR

NP80N055EHE, NP80N055KHE

NP80N055CHE, NP80N055DHE, NP80N055MHE, NP80N055NHE

SWITCHING N-CHANNEL POWER MOS FET

DESCRIPTION

These products are N-channel MOS Field Effect Transistors designed for high current switching applications.

<R> ORDERING INFORMATION

PART NUMBER	LEAD PLATING	PACKING	PACKAGE		
NP80N055EHE-E1-AY Note1, 2			TO 2002 (MD 2571) by: 4.4 m		
NP80N055EHE-E2-AY Note1, 2	Dura Ca (Tia)	Tana 200 n/raal	TO-263 (MP-25ZJ) typ. 1.4 g		
NP80N055KHE-E1-AY Note1	Pure Sn (Tin)	Tape 800 p/reel	TO 000 (MD 05710) L 4.5 .		
NP80N055KHE-E2-AY Note1			TO-263 (MP-25ZK) typ. 1.5 g		
NP80N055CHE-S12-AZ Note1, 2	Sn-Ag-Cu		TO-220 (MP-25) typ. 1.9 g		
NP80N055DHE-S12-AY Note1, 2		Tuba FO altuba	TO-262 (MP-25 Fin Cut) typ. 1.8 g		
NP80N055MHE-S18-AY Note1	Pure Sn (Tin)	Tube 50 p/tube	TO-220 (MP-25K) typ. 1.9 g		
NP80N055NHE-S18-AY Note1			TO-262 (MP-25SK) typ. 1.8 g		

Notes 1. Pb-free (This product does not contain Pb in the external electrode.)

2. Not for new design

FEATURES

- Channel temperature 175 degree rated
- Super low on-state resistance

 $R_{DS(on)}$ = 11 m Ω MAX. (VGS = 10 V, ID = 40 A)

• Low input capacitance

Ciss = 2400 pF TYP.

• Built-in gate protection diode



(TO-220)

(TO-262)



(TO-263)



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ABSOLUTE MAXIMUM RATINGS (TA = 25°C)

Drain to Source Voltage (V _{GS} = 0 V)	VDSS	55	V
Gate to Source Voltage (VDS = 0 V)	Vgss	±20	V
Drain Current (DC) (Tc = 25°C) Note1	I _{D(DC)}	±80	Α
Drain Current (Pulse) Note2	D(pulse)	±200	Α
Total Power Dissipation (T _A = 25°C)	PT	1.8	W
Total Power Dissipation (Tc = 25°C)	Рт	120	W
Channel Temperature	Tch	175	°C
Storage Temperature	T _{stg}	-55 to +175	°C
Single Avalanche Current Note3	las	45/31/10	Α
Single Avalanche Energy Note3	Eas	2.0/96/100	mJ

Notes 1. Calculated constant current according to MAX. allowable channel temperature.

- **2.** PW \leq 10 μ s, Duty cycle \leq 1%
- 3. Starting T_{ch} = 25°C, V_{DD} = 28 V, R_G = 25 Ω , V_{GS} = 20 \rightarrow 0 V (See Figure 4.)

THERMAL RESISTANCE

Channel to Case Thermal Resistance	Rth(ch-C)	1.25	°C/W
Channel to Ambient Thermal Resistance	Rth(ch-A)	83.3	°C/W

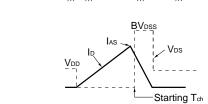


ELECTRICAL CHARACTERISTICS (TA = 25°C)

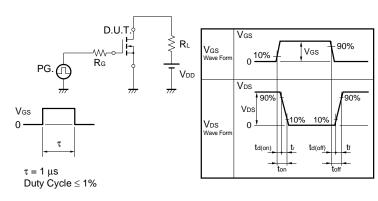
CHARACTERISTICS	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Zero Gate Voltage Drain Current	IDSS	V _{DS} = 55 V, V _{GS} = 0 V			10	μΑ
Gate Leakage Current	Igss	V _{GS} = ±20 V, V _{DS} = 0 V			±10	μΑ
Gate to Source Threshold Voltage	V _{GS(th)}	V _{DS} = V _{GS} , I _D = 250 μA	2.0	3.0	4.0	V
Forward Transfer Admittance	yfs	V _{DS} = 10 V, I _D = 40 A	12	30		S
Drain to Source On-state Resistance	R _{DS(on)}	V _{GS} = 10 V, I _D = 40 A		8.2	11	mΩ
Input Capacitance	Ciss	V _{DS} = 25 V,		2400	3600	pF
Output Capacitance	Coss	V _{GS} = 0 V,		380	570	pF
Reverse Transfer Capacitance	Crss	f = 1 MHz		180	330	pF
Turn-on Delay Time	t _{d(on)}	V _{DD} = 28 V, I _D = 40 A,		25	55	ns
Rise Time	tr	V _{GS} = 10 V,		13	32	ns
Turn-off Delay Time	t _{d(off)}	R _G = 1 Ω		45	91	ns
Fall Time	t _f			13	33	ns
Total Gate Charge	QG	V _{DD} = 44 V,		40	60	nC
Gate to Source Charge	Qgs	V _{GS} = 10 V,		12		nC
Gate to Drain Charge	Q _{GD}	I _D = 80 A		16		nC
Body Diode Forward Voltage	V _{F(S-D)}	I _F = 80 A, V _{GS} = 0 V		1.0		V
Reverse Recovery Time	trr	I _F = 80 A, V _{GS} = 0 V,		49		ns
Reverse Recovery Charge	Qrr	di/dt = 100 A/ <i>μ</i> s		90		nC

TEST CIRCUIT 1 AVALANCHE CAPABILITY

$\begin{array}{c} \text{D.U.T.} \\ \text{Rg} = 25 \Omega \\ \text{Vgs} = 20 \rightarrow 0 \end{array} \begin{array}{c} \text{PG.} \\ \text{$>$} 50 \Omega \\ \text{$>$} \end{array} \begin{array}{c} \text{V_{DD}} \end{array}$



TEST CIRCUIT 2 SWITCHING TIME



TEST CIRCUIT 3 GATE CHARGE

$$\begin{array}{c|c} D.U.T. \\ \hline IG = 2 \text{ mA} \\ \hline \downarrow V_{DL} \\ \hline \end{array}$$

40

20

0

25

50 75

TYPICAL CHARACTERISTICS (TA = 25°C)

Figure 1. DERATING FACTOR OF FORWARD BIAS SAFE OPERATING AREA

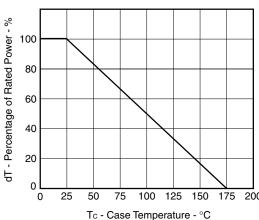


Figure 3. FORWARD BIAS SAFE OPERATING AREA

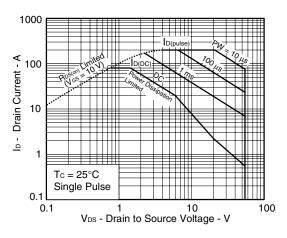


Figure2. TOTAL POWER DISSIPATION vs. CASE TEMPERATURE 140 P_T - Total Power Dissipation - W 120 100 80 60



125

Figure 4. SINGLE AVALANCHE ENERGY DERATING FACTOR

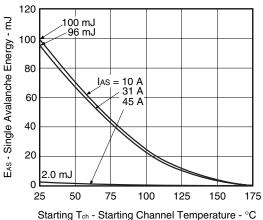
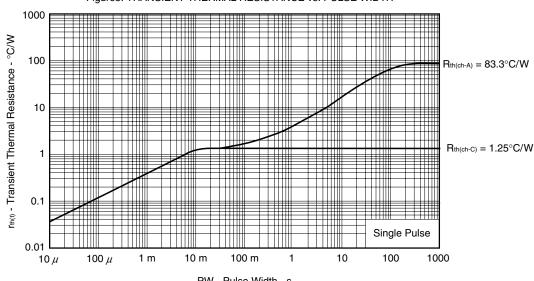


Figure 5. TRANSIENT THERMAL RESISTANCE vs. PULSE WIDTH



PW - Pulse Width - s

Figure 6. FORWARD TRANSFER CHARACTERISTICS

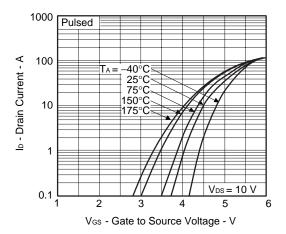


Figure8. FORWARD TRANSFER ADMITTANCE vs. DRAIN CURRENT

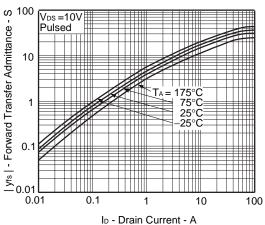


Figure 10. DRAIN TO SOURCE ON-STATE RESISTANCE vs. DRAIN CURRENT

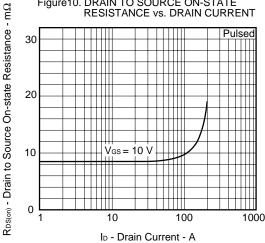
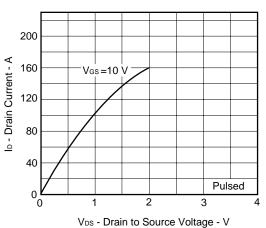


Figure 7. DRAIN CURRENT vs. DRAIN TO SOURCE VOLTAGE



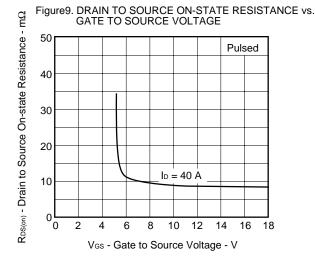
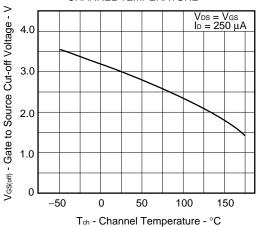
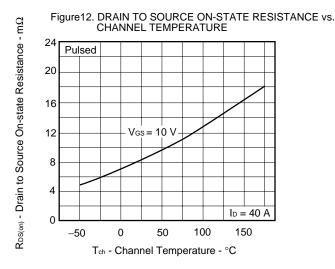


Figure 11. GATE TO SOURCE CUT-OFF VOLTAGE vs. CHANNEL TEMPERATURE

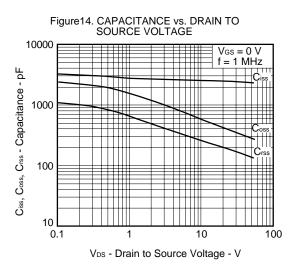


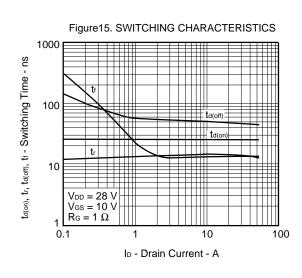


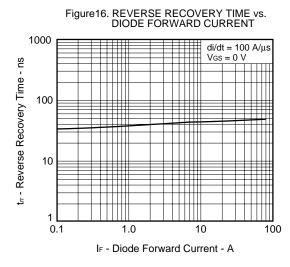
FORWARD VOLTAGE

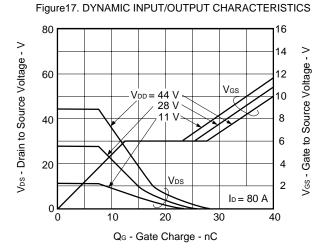
1000
Pulsed
1000
VGS = 10 V
0 V
0 V
100
0.1
0.5
1.5
VF(S-D) - Source to Drain Voltage - V

Figure 13. SOURCE TO DRAIN DIODE

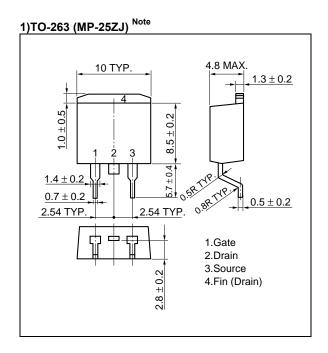


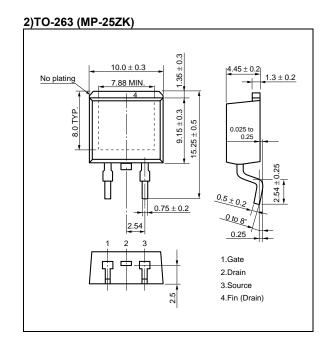


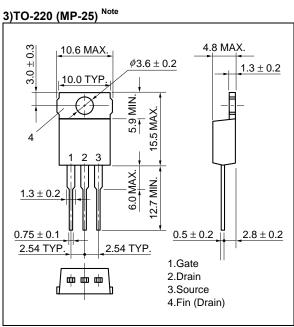


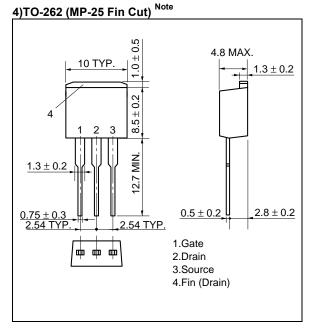


<R> PACKAGE DRAWINGS (Unit: mm)

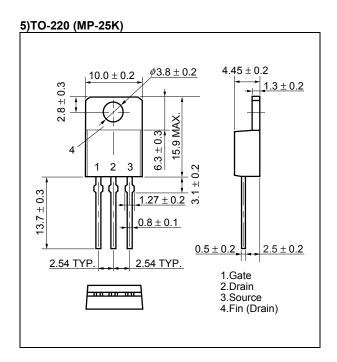


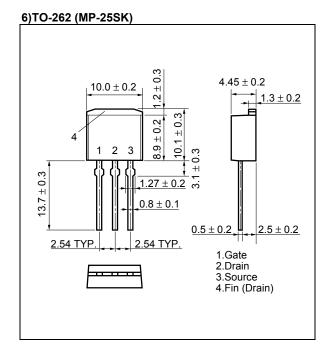




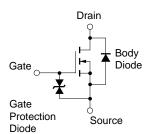


Note Not for new design





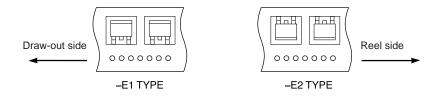
EQUIVALENT CIRCUIT



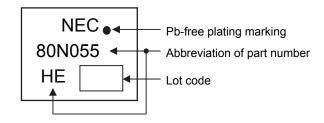
Remark The diode connected between the gate and source of the transistor serves as a protector against ESD. When this device actually used, an additional protection circuit is externally required if a voltage exceeding the rated voltage may be applied to this device.

<R> TAPE INFORMATION

There are two types (-E1, -E2) of taping depending on the direction of the device.



<R> MARKING INFORMATION



<R> RECOMMENDED SOLDERING CONDITIONS

These products should be soldered and mounted under the following recommended conditions.

For soldering methods and conditions other than those recommended below, please contact an NEC Electronics sales representative.

For technical information, see the following website.

Semiconductor Device Mount Manual (http://www.necel.com/pkg/en/mount/index.html)

Soldering Method	Soldering Conditions	Recommended Condition Symbol	
Infrared reflow	Maximum temperature (Package's surface temperature): 260°C or below		
MP-25ZJ, MP-25ZK	Time at maximum temperature: 10 seconds or less		
	Time of temperature higher than 220°C: 60 seconds or less	ID00 00 0	
	Preheating time at 160 to 180°C: 60 to 120 seconds	IR60-00-3	
	Maximum number of reflow processes: 3 times		
	Maximum chlorine content of rosin flux (percentage mass): 0.2% or less		
Wave soldering	Maximum temperature (Solder temperature): 260°C or below		
MP-25, MP-25K, MP-25SK,	Time: 10 seconds or less	THDWS	
MP-25 Fin Cut	Maximum chlorine content of rosin flux: 0.2% (wt.) or less		
Partial heating	Maximum temperature (Pin temperature): 350°C or below		
MP-25ZJ, MP-25ZK,	Time (per side of the device): 3 seconds or less	P350	
MP-25K, MP-25SK	Maximum chlorine content of rosin flux: 0.2% (wt.) or less		
Partial heating	Maximum temperature (Pin temperature): 300°C or below		
MP-25, MP-25 Fin Cut	Time (per side of the device): 3 seconds or less	P300	
	Maximum chlorine content of rosin flux: 0.2% (wt.) or less		

Caution Do not use different soldering methods together (except for partial heating).

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